Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/645,815	BOUTAGHOU ET AL.	
Examiner	Art Unit	
Tianjie Chen	2656	

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Class	Subclass	Date	Examiner
Updated		2/24/2006	TJ
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
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